

## Description

The 9DBL0255/9DBL0455 are 2 and 4-output PCIe Clock fan-out buffers for PCIe Gen1–7 applications. Both parts have an open drain Loss of Signal (LOS) output to indicate the absence or presence of an input clock. The LOS circuit also implements Automatic Clock Parking (ACP) to cleanly park the outputs low/low when the input clock goes away. The devices implement several additional features to aid robust designs. Flexible Power Sequencing (FPS) ensures well-defined behavior under various power up scenarios, while Power Down Tolerant (PDT) ESD protection allows input pins to be driven before VDD is applied. The 9DBL0255/9DBL0455 are spread-spectrum compatible and provide direct connection to 85Ω transmission lines. They can also be used in 100Ω environments with simple external series resistors.

## PCIe Architectures

- Common Clocked (CC)
- Independent Reference Clock (SRIS, SRnS)

## Typical Applications

- PCIe clock distribution in:
  - PCIe Riser Cards
  - NVME eSSD and JBOD
  - High-Performance Computing and Accelerators

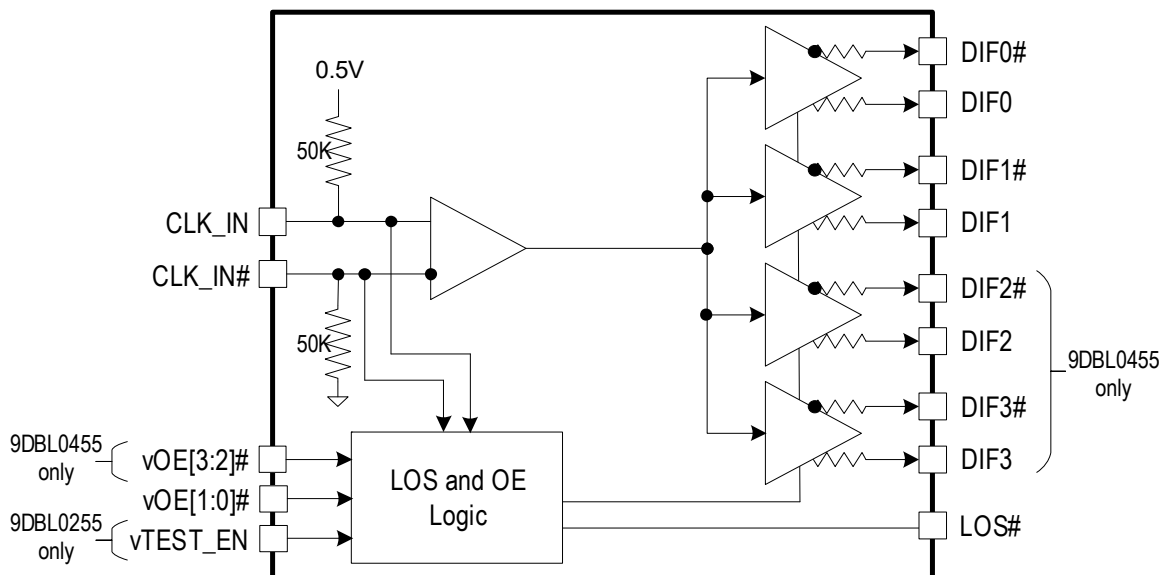
## Features

- FPS: VDD may be applied with floating input clock, or input clock may be driven before VDD is applied
- ACP: Outputs automatically park low/low when LOS occurs and cleanly start when LOS is removed
- PDT: Input pins may be driven before VDD is applied and will not damage the device
- 2 or 4 Low-power HCSL (LP-HCSL) DIF pairs
- 85Ω loads require 0 termination resistors
- 100Ω loads require only 2 series resistors per output
- OE# pin for each output
- Spread-spectrum tolerant
- Industrial temperature range (-40°C to +85°C)
- Space saving 3 × 3 mm 16-VFQFPN (9DBL0255)
- Space saving 4 × 4 mm 20-VFQFPN (9DBL0455)
- Easy AC-coupling to other logic families. See application note [AN-891](#).

## Key Specifications

- Input-to-output delay < 3ns
- Output-to-output skew < 50ps
- Operating frequency up to 267MHz (9DBL0455)
- Additive phase jitter < 6fs RMS for PCIe Gen7
- Additive phase jitter 46fs RMS (typical) at 156.25MHz (12kHz–20MHz)

## Block Diagram

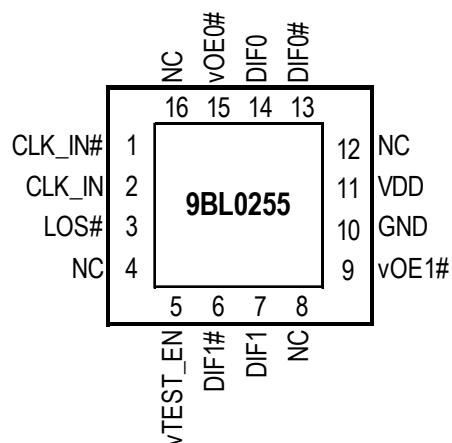


# Contents

Description . . . . .	1
PCIe Architectures . . . . .	1
Typical Applications . . . . .	1
Features . . . . .	1
Key Specifications . . . . .	1
Block Diagram . . . . .	1
Pin Assignments . . . . .	3
9DBL0255 Pin Descriptions . . . . .	4
9DBL0455 Pin Descriptions . . . . .	4
Power Management . . . . .	5
Absolute Maximum Ratings . . . . .	6
Thermal Characteristics . . . . .	6
Electrical Characteristics . . . . .	7
Test Loads . . . . .	11
Alternate Terminations . . . . .	11
Package Outline Drawings . . . . .	12
Marking Diagrams . . . . .	12
Ordering Information . . . . .	12
Revision History . . . . .	13

# Pin Assignments

**Figure 1. Pin Assignments for 3 × 3 mm 16-VFQFPN Package – Top View**

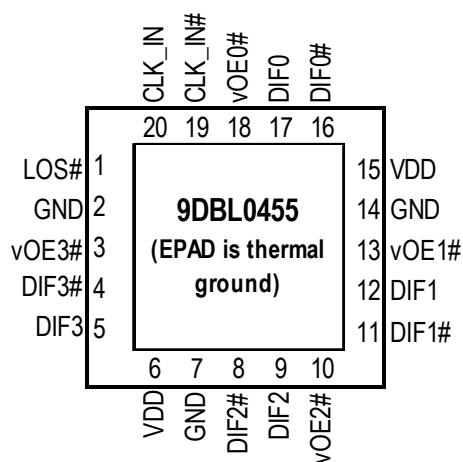


**16-VFQFPN, 3 × 3mm, 0.5mm pitch**

^ prefix indicates internal 120kOhm pull-up resistor

v prefix indicates internal 120kOhm pull-down resistor

**Figure 2. Pin Assignments for 4 × 4 mm 20-VFQFPN Package – Top View**



**20-VFQFPN, 4 x 4 mm, 0.5mm pitch**

^ prefix indicates internal pull-up resistor

v prefix indicates internal pull-down resistor

## 9DBL0255 Pin Descriptions

**Table 1. 9DBL0255 Pin Descriptions**

Number	Name	Type	Description
1	CLK_IN#	Input	Complementary input for differential reference clock.
2	CLK_IN	Input	True input for differential reference clock.
3	LOS#	Open Drain Out	Output indicating Loss of Input Signal. This pin is an open drain output and requires an external pull up resistor for proper functionality. A low output on this pin indicates a loss of signal on the input clock.
4	NC	—	No connection.
5	vTEST_EN	Input	Test Enable Pin for forcing the outputs during board test. It has an internal pull down. See the <a href="#">Test Mode (9DBL0255 only)</a> table for additional details.
6	DIF1#	Output	Differential complementary clock output.
7	DIF1	Output	Differential true clock output.
8	NC	—	No connection.
9	vOE1#	Input	Active low input for enabling output 1. This pin has an internal pull-down. 1 = disable output, 0 = enable output.
10	GND	GND	Ground pin.
11	VDD	Power	Power supply, nominally 3.3V.
12	NC	—	No connection.
13	DIF0#	Output	Differential complementary clock output.
14	DIF0	Output	Differential true clock output.
15	vOE0#	Input	Active low input for enabling output 0. This pin has an internal pull-down. 1 = disable output, 0 = enable output.
16	NC	—	No connection.
17	EPAD	GND	Connect EPAD to ground.

## 9DBL0455 Pin Descriptions

**Table 2. 9DBL0455 Pin Descriptions**

Number	Name	Type	Description
1	LOS#	Open Drain Out	Output indicating Loss of Input Signal. This pin is an open drain output and requires an external pull up resistor for proper functionality. A low output on this pin indicates a loss of signal on the input clock.
2	GND	GND	Ground pin.
3	vOE3#	Input	Active low input for enabling output 3. This pin has an internal pull-down. 1 = disable output, 0 = enable output.
4	DIF3#	Output	Differential complementary clock output.
5	DIF3	Output	Differential true clock output.
6	VDD	Power	Power supply, nominally 3.3V.

**Table 2. 9DBL0455 Pin Descriptions (Cont.)**

Number	Name	Type	Description
7	GND	GND	Ground pin.
8	DIF2#	Output	Differential complementary clock output.
9	DIF2	Output	Differential true clock output.
10	vOE2#	Input	Active low input for enabling output 2. This pin has an internal pull-down. 1 = disable output, 0 = enable output.
11	DIF1#	Output	Differential complementary clock output.
12	DIF1	Output	Differential true clock output.
13	vOE1#	Input	Active low input for enabling output 1. This pin has an internal pull-down. 1 = disable output, 0 = enable output.
14	GND	GND	Ground pin.
15	VDD	Power	Power supply, nominally 3.3V.
16	DIF0#	Output	Differential complementary clock output.
17	DIF0	Output	Differential true clock output.
18	vOE0#	Input	Active low input for enabling output 0. This pin has an internal pull-down. 1 = disable output, 0 = enable output.
19	CLK_IN#	Input	Complementary input for differential reference clock.
20	CLK_IN	Input	True input for differential reference clock.
21	EPAD	GND	Connect to Ground.

## Power Management

**Table 3. Power Management**

CLK_IN	OEx# Pin	DIFx	DIFx#
Floating <sup>[a]</sup>	x	Low	Low
Stopped	x	Low	Low
Running	1	Low	Low
Running	0	Running	Running

[a] The CLK\_IN has an internal network that biases the clock input to a differential '1' state.

**Table 4. Test Mode (9DBL0255 only)**

TEST_EN	OEx# Pin	DIFx	DIFx#
x	0	Normal Operation	
0	1	Low	Low
1	1	High	High

## Absolute Maximum Ratings

The absolute maximum ratings are stress ratings only. Stresses greater than those listed below can cause permanent damage to the device. Functional operation of the 9DBL0255/9DBL0455 at absolute maximum ratings is not implied. Exposure to absolute maximum rating conditions may affect device reliability.

**Table 5. Absolute Maximum Ratings**

Parameter	Symbol	Conditions	Minimum	Typical	Maximum	Unit	Notes
Supply Voltage	$V_{DDx}$		-	-	3.9	V	1,2
Input Voltage	$V_{IN}$	Single-ended control inputs.	-0.5	-	3.9	V	1
Input High Voltage, SMBus	$V_{IHSMB}$	SMBus clock and data pins.	-	-	3.9	V	1
Junction temperature	$T_J$		-65	-	150	°C	1
Storage temperature	$T_S$		-	-	125	°C	1
Input ESD Protection	ESD prot	Human Body Model.	2000	-	-	V	1

<sup>1</sup> Confirmed by design and characterization, not 100% tested in production.

<sup>2</sup> Operation under these conditions is neither implied nor guaranteed.

## Thermal Characteristics

**Table 6. Thermal Characteristics**

Parameter	Symbol	Conditions	Package	Typical Value	Unit	Notes
Thermal Resistance	$\theta_{JC}$	Junction to case.	9DBL0255 NLG16P3	66	°C/W	1
	$\theta_{Jb}$	Junction to base.		5.1	°C/W	1
	$\theta_{JA0}$	Junction to air, still air.		63	°C/W	1
	$\theta_{JA1}$	Junction to air, 1 m/s air flow.		56	°C/W	1
	$\theta_{JA3}$	Junction to air, 3 m/s air flow.		51	°C/W	1
	$\theta_{JA5}$	Junction to air, 5 m/s air flow.		49	°C/W	1
Thermal Resistance	$\theta_{JC}$	Junction to case.	9DBL0455 NLG20P1	65.8	°C/W	1
	$\theta_{Jb}$	Junction to base.		5.1	°C/W	1
	$\theta_{JA0}$	Junction to air, still air.		63.2	°C/W	1
	$\theta_{JA1}$	Junction to air, 1 m/s air flow.		55.9	°C/W	1
	$\theta_{JA3}$	Junction to air, 3 m/s air flow.		51.4	°C/W	1
	$\theta_{JA5}$	Junction to air, 5 m/s air flow.		49.2	°C/W	1

<sup>1</sup> EPAD soldered to board.

# Electrical Characteristics

$T_A = T_{AMB}$ , supply voltages per normal operation condition. See [Test Loads](#) for loading conditions.

**Table 7. CLK\_IN Clock Input Parameters**

Parameter	Symbol	Conditions	Minimum	Typical	Maximum	Unit	Notes
Input Crossover Voltage	$V_{CROSS}$	Crossover voltage.	150	-	900	mV	1
Input Swing	$V_{SWING}$	Differential value ( $\pm 150$ mV single-ended).	300	-	-	mV	1
Input Slew Rate	$dv/dt$	Measured differentially.	0.6	-	8	V/ns	1,2

<sup>1</sup> Confirmed by design and characterization, not 100% tested in production.

<sup>2</sup> Slew rate measured through  $\pm 75$ mV window centered around differential zero.

**Table 8. Input/Supply/Common Parameters – Normal Operating Conditions**

Parameter	Symbol	Conditions	Minimum	Typical	Maximum	Unit	Notes
Supply Voltage	$V_{DD}$	Supply voltage.	3.135	3.3	3.465	V	
Pull-up Voltage	$V_{DDPup}$	Pull-up voltage for LOS# pin.	-	-	3.465	V	
Ambient Operating Temperature	$T_{AMB}$	Industrial range.	-40	25	85	°C	
Input High Voltage	$V_{IH}$	Single-ended inputs.	$0.75 V_{DDx}$	-	$V_{DDx} + 0.3$	V	
Input Low Voltage	$V_{IL}$		-0.3	-	$0.25 V_{DDx}$	V	
Output High Voltage	$V_{OH}$	LOS# output (1k $\Omega$ pull resistor, $V_{DDPup} = 3.3$ V).	$0.9 V_{DDPup}$	-	$V_{DDPup}$	V	
Output Low Voltage	$V_{OL}$		-0.3	-	$0.15 V_{DDPup}$	V	
Input Current	$I_{IN}$	Single-ended inputs, $V_{IN} = GND$ , $V_{IN} = V_{DD}$ .	-5	-	5	$\mu$ A	
	$I_{INP}$	Single-ended inputs. $V_{IN} = 0$ V; inputs with internal pull-up resistors. $V_{IN} = V_{DD}$ ; inputs with internal pull-down resistors.	-50	-	100	$\mu$ A	
Input Frequency	$F_{IN}$	9DBL0255	10	-	220	MHz	
		9DBL0455	10	-	267		
Pin Inductance	$L_{pin}$			-	7	nH	1
Capacitance	$C_{IN}$	Logic inputs, except CLK_IN.	1.5	-	5	pF	1
	$C_{INCLK\_IN}$	CLK_IN differential clock inputs.	1.5	-	2.7	pF	1
	$C_{OUT}$	Output pin capacitance.	-	-	6	pF	1
Clk Stabilization	$t_{STAB}$	From $V_{DD}$ valid, input clock stabilization and OE# pins low.	-	224	300	$\mu$ s	1,2
LOS# De-assertion Time	$t_{LOS\#\_De-assert}$	Time for LOS# to de-assert after return of input clock.	-	224	300	$\mu$ s	1
LOS# Assertion Time	$t_{LOS\#\_Assert}$	Time for LOS# to assert after loss of input clock.	-	73	100	ns	1

**Table 8. Input/Supply/Common Parameters – Normal Operating Conditions**

Parameter	Symbol	Conditions	Minimum	Typical	Maximum	Unit	Notes
OE# Latency	$t_{LATO\#}$	DIF start after OE# assertion. DIF stop after OE# deassertion.	1	-	3	clocks	1,3
Tfall	$t_F$	Fall time of single-ended control inputs.	-	-	5	ns	2
Trise	$t_R$	Rise time of single-ended control inputs.	-	-	5	ns	2

<sup>1</sup> Confirmed by design and characterization, not 100% tested in production.

<sup>2</sup> Control input must be monotonic from 20% to 80% of input swing.

<sup>3</sup> Time from deassertion until outputs are > 200mV, assuming input clock is running.

**Table 9. Current Consumption**

Parameter	Symbol	Conditions	Minimum	Typical	Maximum	Unit	Notes
Operating Supply Current (9DBL0255)	$I_{DD}$	220MHz, all outputs running.	-	26	36	mA	
		100MHz, all outputs running.	-	14	20	mA	
Operating Supply Current (9DBL0455)	$I_{DD}$	267MHz, all outputs running	-	48	65	mA	
		100MHz, all outputs running.	-	24	33	mA	
Powerdown Current	$I_{DDRPD}$	Input clock stopped.	-	1.7	2.5	mA	1

<sup>1</sup> Input clock stopped.

**Table 10. Output Duty Cycle, Jitter, and Skew Characteristics**

Parameter	Symbol	Conditions	Minimum	Typical	Maximum	Unit	Notes
Duty Cycle Distortion	$t_{DCD}$	Measured differentially, 100MHz.	0	0.4	0.7	%	1,3
Skew, Input to Output	$t_{pd}$	$V_T = 50\%$ , $V_{SWING} > 600mV$ ( $\pm 300mV$ single-ended).	1.5	2.2	3.0	ns	1,2,5
		$V_T = 50\%$ , $400mV \leq V_{SWING} \leq 600mV$ ( $\pm 200mV$ to $\pm 300mV$ single-ended).	1.9	2.8	3.7	ns	1,2,6
		$V_T = 50\%$ , $300mV \leq V_{SWING} < 400mV$ ( $\pm 150mV$ to $\pm 200mV$ single-ended).	2.9	3.9	4.9	ns	1,2
Skew, Output to Output	$t_{sk3}$	$V_T = 50\%$ , 9DBL0255.	-	2	15	ps	2,4
		$V_T = 50\%$ , 9DBL0455.	-	14	25	ps	1,2,4

<sup>1</sup> Applies to all differential outputs, confirmed by design and characterization.

<sup>2</sup> Measured from differential waveform.

<sup>3</sup> Duty cycle distortion is the difference in duty cycle between the output and the input clock.

<sup>4</sup> All outputs equally loaded.

<sup>5</sup> The maximum absolute difference between minimum and maximum  $t_{pd}$  at any given  $V_{SWING}$  in this range is 1.15ns.

<sup>6</sup> The maximum absolute difference between minimum and maximum  $t_{pd}$  at any given  $V_{SWING}$  in this range is 1.4ns.



**Table 11. LP-HCSL Outputs – 9DBL0255**

T<sub>AMB</sub> = over the specified operating range. Supply voltages per normal operation conditions. See [Test Loads](#) for loading conditions.

Parameter	Symbol	Conditions	Minimum	Typical	Maximum	Limit	Unit	Notes
Slew Rate	dV/dt	Scope averaging on.	3.0	3.4	3.9	1–5	V/ns	1,2,3
Slew Rate Matching	$\Delta$ dV/dt	Single-ended measurement.	-	5	11	20	%	1,4,7
Max Voltage	V <sub>max</sub>	Measurement on single-ended signal using absolute value (scope averaging off).	800	843	885	660–1150	mV	7,8
Min Voltage	V <sub>min</sub>		-104	-74	-47	-300–150		7,8
Crossing Voltage (abs)	V <sub>cross_abs</sub>	Scope averaging off.	324	367	421	250–550	mV	1,5,7
Crossing Voltage (var)	$\Delta$ -V <sub>cross</sub>	Scope averaging off.	-	21	71	140	mV	1,6,7

**Table 12. LP-HCSL Outputs – 9DBL0455**

T<sub>AMB</sub> = over the specified operating range. Supply voltages per normal operation conditions. See [Test Loads](#) for loading conditions.

Parameter	Symbol	Conditions	Minimum	Typical	Maximum	Limit	Unit	Notes
Slew Rate	dV/dt	Scope averaging on.	3.8	4.4	5	1–5	V/ns	1,2,3
Slew Rate Matching	$\Delta$ dV/dt	Single-ended measurement.	-	7	15	20	%	1,4,7
Max Voltage	V <sub>max</sub>	Measurement on single-ended signal using absolute value (scope averaging off).	804	846	888	660–1150	mV	7,8
Min Voltage	V <sub>min</sub>		-154	-109	-62	-300–150		7,8
Crossing Voltage (abs)	V <sub>cross_abs</sub>	Scope averaging off.	278	347	415	250–550	mV	1,5,7
Crossing Voltage (var)	$\Delta$ -V <sub>cross</sub>	Scope averaging off.	-	18	25	140	mV	1,6,7

**Notes for LP-HCSL Outputs tables:**

- <sup>1</sup> Confirmed by design and characterization, not 100% tested in production.
- <sup>2</sup> Measured from differential waveform.
- <sup>3</sup> Slew rate is measured through the V<sub>swing</sub> voltage range centered around differential 0V. This results in a  $\pm$ 150mV window around differential 0V.
- <sup>4</sup> Matching applies to rising edge rate for Clock and falling edge rate for Clock#. It is measured using a  $\pm$ 75mV window centered on the average cross point where Clock rising meets Clock# falling. The median cross point is used to calculate the voltage thresholds the oscilloscope is to use for the edge rate calculations.
- <sup>5</sup> V<sub>cross</sub> is defined as voltage where Clock = Clock# measured on a component test board and only applies to the differential rising edge (i.e. Clock rising and Clock# falling).
- <sup>6</sup> The total variation of all V<sub>cross</sub> measurements in any particular system. Note that this is a subset of V<sub>cross\_min/max</sub> (V<sub>cross</sub> absolute) allowed. The intent is to limit V<sub>cross</sub> induced modulation by setting  $\Delta$ -V<sub>cross</sub> to be smaller than V<sub>cross</sub> absolute.

**Table 13. Additive Phase Jitter for Fanout Buffers**

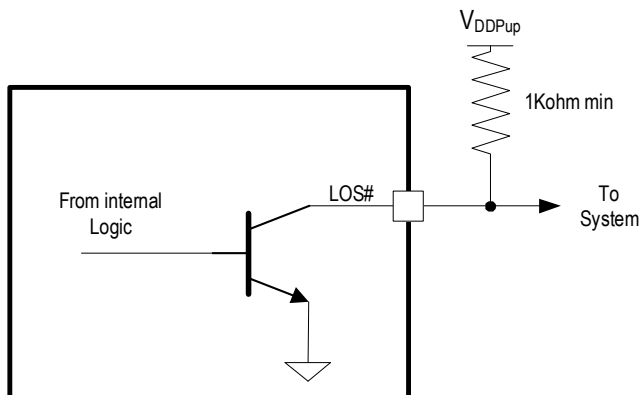
T<sub>AMB</sub> = over the specified operating range. Supply voltages per normal operation conditions. See [Test Loads](#) for loading conditions.

Parameter	Symbol	Conditions	Min.	Typ.	Max.	Limit	Units	Notes
Additive PCIe Phase Jitter (Common Clocked Architecture)	t <sub>jph</sub> PCleG1-CC	PCle Gen 1 (2.5 GT/s)	-	856	1294	86000	fs (pk-pk)	1, 2
	t <sub>jph</sub> PCleG2-CC	PCle Gen 2 Hi Band (5.0 GT/s)	-	73	110	3100	fs (RMS)	1, 2
		PCle Gen 2 Lo Band (5.0 GT/s)	-	22	32	3000	fs (RMS)	1, 2
	t <sub>jph</sub> PCleG3-CC	PCle Gen 3 (8.0 GT/s)	-	24	37	1000	fs (RMS)	1, 2
	t <sub>jph</sub> PCleG4-CC	PCle Gen 4 (16.0 GT/s)	-	24	37	500	fs (RMS)	1, 2, 3, 4
	t <sub>jph</sub> PCleG5-CC	PCle Gen 5 (32.0 GT/s)	-	10	15	150	fs (RMS)	1, 2, 3, 5
	t <sub>jph</sub> PCleG6-CC	PCle Gen 6 (64.0 GT/s)	-	6	9	100	fs (RMS)	1, 2, 3, 6
	t <sub>jph</sub> PCleG7-CC	PCle Gen 7 (64.0 GT/s)	-	4	6	67	fs (RMS)	1, 2, 3, 7
Additive PCIe Phase Jitter (IR Architecture)	t <sub>jph</sub> PCleG2-IR	PCle Gen 2 Band (5.0 GT/s)	-	59	90	N/A	fs (RMS)	1, 2, 8
	t <sub>jph</sub> PCleG3-IR	PCle Gen 3 (8.0 GT/s)	-	24	36	N/A	fs (RMS)	1, 2, 8
	t <sub>jph</sub> PCleG4-IR	PCle Gen 4 (16.0 GT/s)	-	24	37	N/A	fs (RMS)	1, 2, 8
	t <sub>jph</sub> PCleG5-IR	PCle Gen 5 (32.0 GT/s)	-	7	10	N/A	fs (RMS)	1, 2, 8
	t <sub>jph</sub> PCleG6-IR	PCle Gen 6 (64.0 GT/s)	-	5	7	N/A	fs (RMS)	1, 2, 8
	t <sub>jph</sub> PCleG7-IR	PCle Gen 7 (64.0 GT/s)	-	3	5	N/A	fs (RMS)	1, 2, 8
Additive Phase Jitter (12kHz-20MHz)	t <sub>jph</sub> PCle12k-20M	156.25MHz	-	46	54	N/A	fs (RMS)	N/A

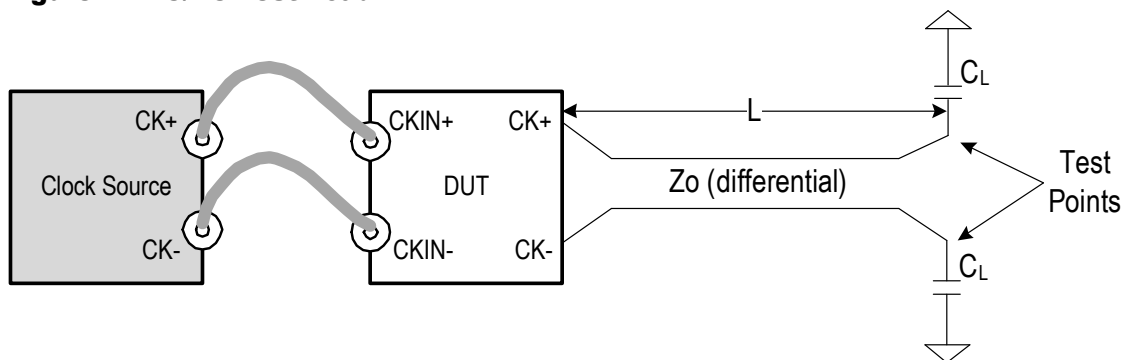
1. The Refclk jitter is measured after applying the filter functions found in the *PCI Express Base Specification 7.0*, Revision 0.7. For the exact measurement setup, see [Test Loads](#). The worst case results for each data rate are summarized in this table. Equipment noise is removed from all measurements.
2. Jitter measurements should be made with a capture of at least 100,000 clock cycles captured by a real-time oscilloscope (RTO) with a sample rate of 20GS/s or greater. Broadband oscilloscope noise must be minimized in the measurement. The measured PP jitter is used (no extrapolation) for RTO measurements. Alternately, jitter measurements can be used with a Phase Noise Analyzer (PNA) extending (flat) and integrating and folding the frequency content up to an offset from the carrier frequency of at least 200MHz (at 300MHz absolute frequency) below the Nyquist frequency. For PNA measurements for the 2.5GT/s data rate, the RMS jitter is converted to peak-to-peak jitter using a multiplication factor of 8.83.
3. SSC spurs from the fundamental and harmonics are removed up to a cutoff frequency of 2MHz taking care to minimize removal of any non-SSC content.
4. 0.7 ps RMS should be used in channel simulations to account for additional noise in a real system.
5. 0.25 ps RMS should be used in channel simulations to account for additional noise in a real system.
6. 0.15 ps RMS should be used in channel simulations to account for additional noise in a real system.
7. 0.10 ps RMS should be used in channel simulations to account for additional noise in a real system.
8. The *PCI Express Base Specification 7.0*, Revision 0.7 provides the filters necessary to calculate SRIS jitter values; it does not provide specification limits, therefore, the reference to this footnote in the Limit column. SRIS values are informative only. A common practice is to split the common clock budget in half. For 16GT/s data rates and above, the user must choose whether to use the output jitter specification, or the input jitter specification, which includes an allocation for the jitter added by the channel. Using 32GT/s, the Refclk jitter budget is 150fs RMS. One half of the Refclk jitter budget is 106fs RMS. At the clock input, the system must deliver 250fs RMS. One half of this value is 177fs RMS. If the clock is placed next to the PCIe device in an SRIS system, the channel is very short and the user can choose to use this more relaxed value as the jitter limit.

## Test Loads

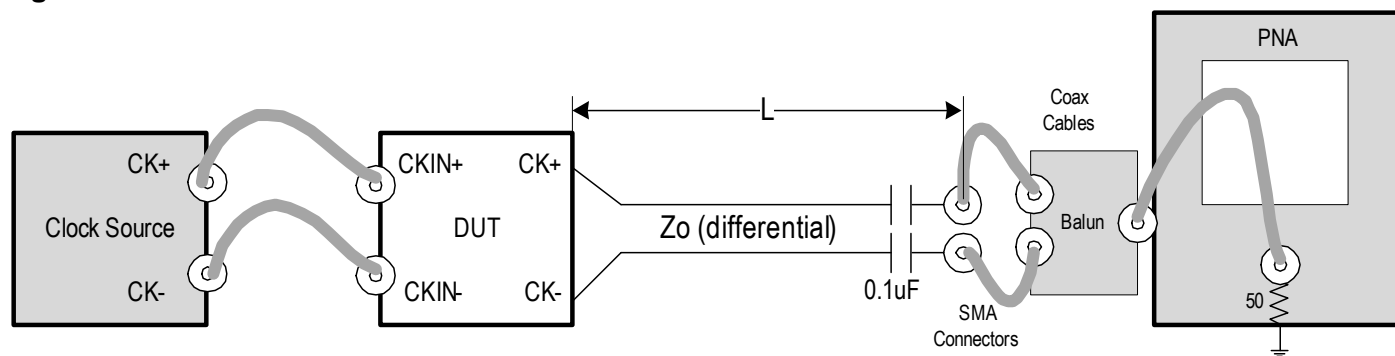
**Figure 3. LOS# Test Load**



**Figure 4. AC/DC Test Load**



**Figure 5. Jitter Measurement Circuit**



**Table 14. Parameters for Output Test Loads**

Clock Source	$R_s$ ( $\Omega$ )	$Z_o$ ( $\Omega$ )	L (inches)	$C_L$ (pF)
SMA100B	Internal	85	5	2
SMA100B	7.5	100	5	2

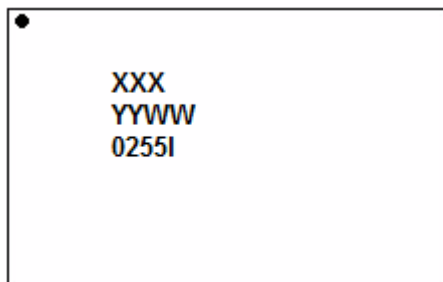
## Alternate Terminations

The 9DBL family can easily drive LVPECL, LVDS, and CML logic. See [“AN-891 Driving LVPECL, LVDS, and CML Logic with “Universal” Low-Power HCSL Outputs”](#) for details.

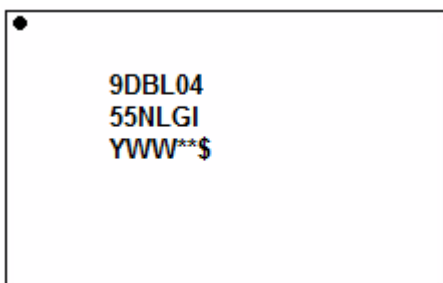
## Package Outline Drawings

The package outline drawings are located at the end of this document and are accessible from the Renesas website (see [Ordering Information](#) for POD links). The package information is the most current data available and is subject to change without revision of this document.

## Marking Diagrams



- Line 1 indicates the last three characters of Asm lot number.
- Line 2 indicates the following:
  - “YY” is the last digits of the year; “WW” is the work week number when the part was assembled.
- Line 3 indicates the truncated part number.



- Lines 1 and 2 indicate the part number.
- Line 3 indicates the following:
  - “Y” is the last digit of the year; “WW” is the work week number when the part was assembled.
  - “\*\*” denotes the lot sequence.
  - “\$” denotes the mark code.

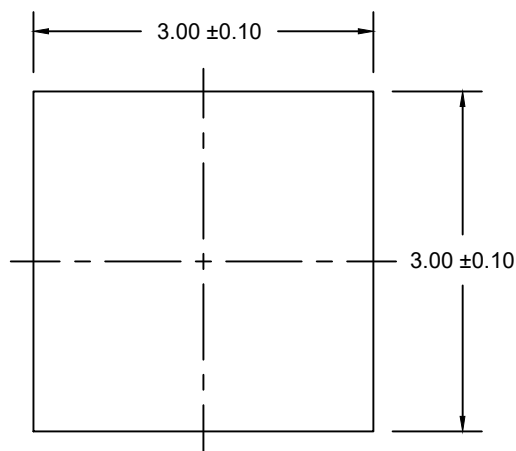
## Ordering Information

Part Number	Carrier Type	Number of Outputs	Package	Temperature Range
9DBL0255NLGI	Tray	2	3 × 3mm, <a href="#">16-VFQFPN</a>	-40° to +85°C
9DBL0255NLGI8	Tape and Reel			
9DBL0455NLGI	Tray	4	4 × 4 mm, <a href="#">20-VFQFPN</a>	
9DBL0455NLGI8	Tape and Reel			

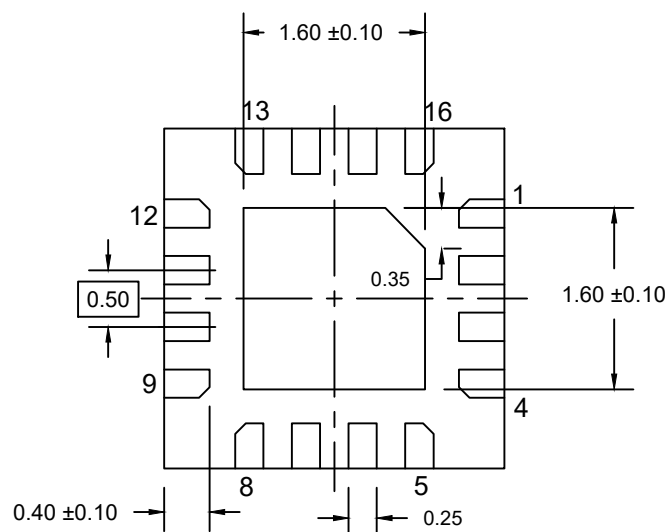
“G” denotes Pb-free, RoHS complaint configuration.

## Revision History

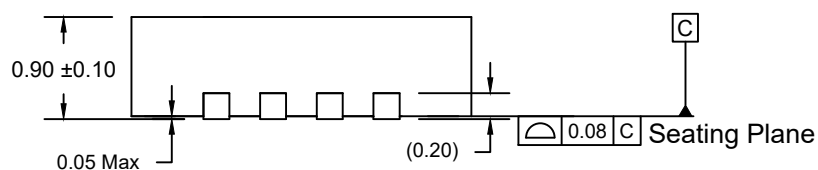
Revision Date	Description of Change
March 5, 2025	<ul style="list-style-type: none"> <li>▪ Updated datasheet title and description to PCIe Gen1-7 from PCIe Gen1-5.</li> <li>▪ Updated <a href="#">Key Specifications</a> to “Additive phase jitter &lt; 6fs for PCIe Gen 7” from “Additive phase Jitter &lt; 15fs RMS for PCIe Gen 5”.</li> </ul>
January 27, 2025	Updated the specifications and footnotes in <a href="#">Table 13</a> .
February 3, 2023	Updated POD link for 20-VFQFPN in <a href="#">Ordering Information</a> .
March 17, 2021	<ul style="list-style-type: none"> <li>▪ Updated front page description text and features bullets.</li> <li>▪ Modified block diagram to indicate pin that are 9DBL0255 only and 9DBL0455 only.</li> <li>▪ Updated Package Outline Drawings section and Ordering Information table.</li> <li>▪ Reformatted to Renesas.</li> </ul>
September 30, 2019	Merged 9DBL0255 and 9DBL0455 into one single document.
August 23, 2019	Initial release.



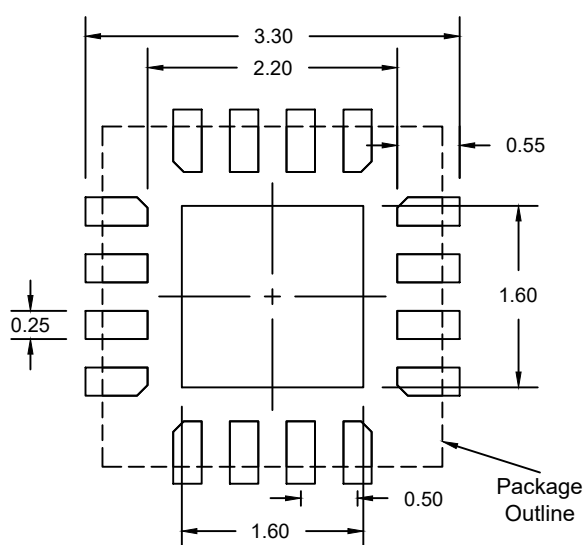
Top View



Side View



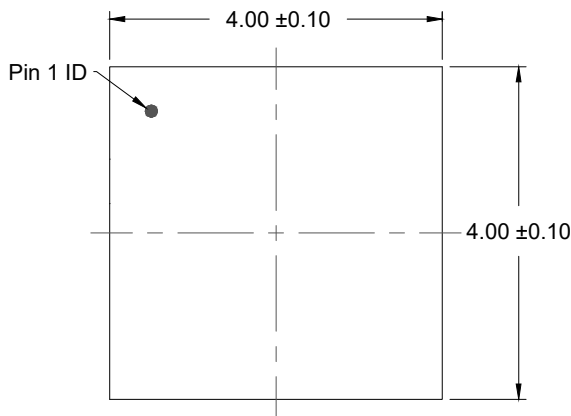
Side View



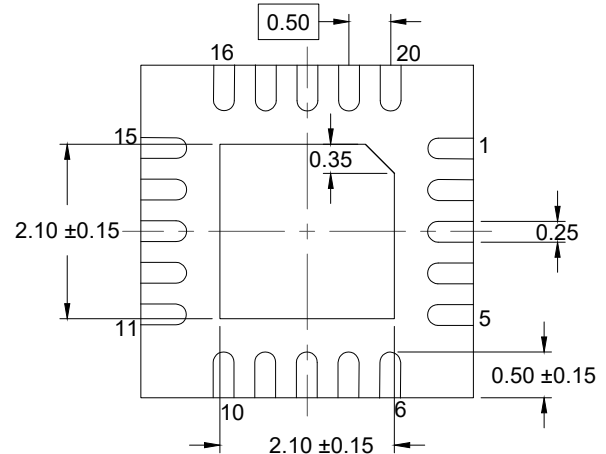
Recommended Land Pattern  
(PCB Top View, NSMD Design)

### Notes:

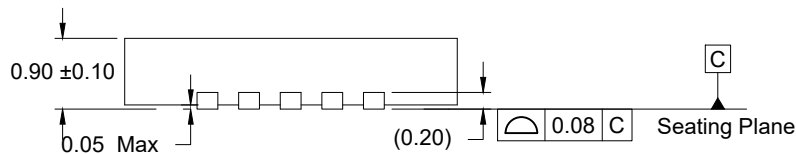
1. JEDEC compatible.
2. All dimensions are in mm. and angle are in degrees.
3. Use  $\pm 0.05$  mm for the non-toleranced dimensions.
4. Numbers in ( ) are for references only.



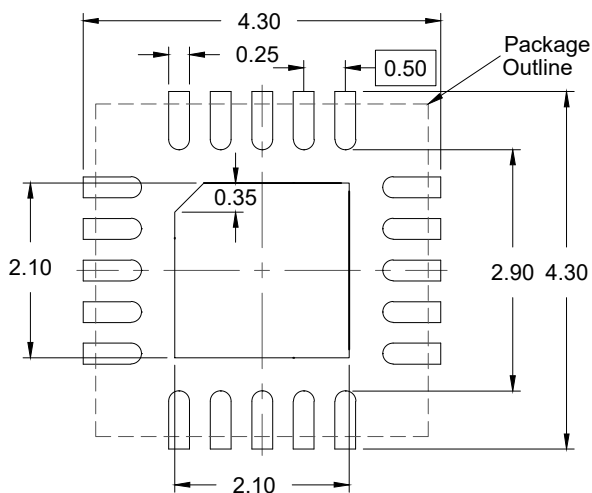
TOP VIEW



BOTTOM VIEW



SIDE VIEW


RECOMMENDED LAND PATTERN  
(PCB Top View, NSMD Design)

## NOTES:

1. JEDEC compatible.
2. All dimensions are in mm and angles are in degrees.
3. Use  $\pm 0.05$  mm for the non-toleranced dimensions.
4. Numbers in ( ) are for references only.

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